



# RADIO TEST REPORT

**Test Report No. : 31IE0013-HO-01-A-R2**

**Applicant** : Weifang Goertek Electronics Co., Ltd  
**Type of Equipment** : Wireless Controller  
**Model No.** : CECH-ZCM1U  
**FCC ID** : SZGCECHZCM1  
**Test regulation** : FCC Part 15 Subpart C: 2010  
**Test Result** : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This report is a revised version of 31IE0013-HO-01-A-R1. 31IE0013-HO-01-A-R1 is replaced with this report.

**Date of test:** April 11 to 14, 2011

**Representative test engineer:**



Takumi Shimada  
Engineer of WiSE Japan,  
UL Verification Service

**Approved by:**



Mitsuru Fujimura  
Leader of WiSE Japan,  
UL Verification Service



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. \*As for the range of Accreditation in NVLAP, you may refer to the WEB address, <http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

**UL Japan, Inc.**

**Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

13-EM-F0429

<b>CONTENTS</b>	<b>PAGE</b>
<b>SECTION 1: Customer information.....</b>	<b>3</b>
<b>SECTION 2: Equipment under test (E.U.T.).....</b>	<b>3</b>
<b>SECTION 3: Test specification, procedures &amp; results.....</b>	<b>4</b>
<b>SECTION 4: Operation of E.U.T. during testing.....</b>	<b>7</b>
<b>SECTION 5: Conducted Emission.....</b>	<b>9</b>
<b>SECTION 6: Radiated Spurious Emission .....</b>	<b>10</b>
<b>SECTION 7: Antenna Terminal Conducted Tests.....</b>	<b>11</b>
<b>APPENDIX 1: Photographs of test setup.....</b>	<b>12</b>
Conducted Emission.....	12
Radiated Spurious Emission.....	13
Worst Case Position (Horizontal: X-axis/ Vertical:Y-axis) .....	14
<b>APPENDIX 2: Data of EMI test.....</b>	<b>16</b>
Conducted Emission.....	16
20dB Bandwidth and Carrier Frequency Separation.....	20
Number of Hopping Frequency.....	23
Dwell time.....	25
Maximum Peak Output Power .....	28
Radiated Spurious Emission.....	29
Conducted Spurious Emission.....	43
Conducted Emission Band Edge compliance.....	50
99%Occupied Bandwidth.....	52
<b>APPENDIX 3: Test instruments .....</b>	<b>54</b>

## **SECTION 1: Customer information**

Company Name : Weifang Goertek Electronics Co., Ltd  
Address : Dongfang North Road Hi-tech Industry Development District, Weifang  
Shandong, China  
Telephone Number : +86-532-88973250  
Facsimile Number : +86-532-88997217  
Contact Person : George Yang

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment : Wireless Controller  
Model No. : CECH-ZCM1U  
Serial No. : Refer to Section 4, Clause 4.2  
Receipt Date of Sample : April 7, 2011  
Country of Mass-production : China  
Condition of EUT : Production prototype  
(Not for Sale: This sample is equivalent to mass-produced items.)  
Modification of EUT : No Modification by the test lab

### **2.2 Product Description**

Model No: CECH-ZCM1U (referred to as the EUT in this report) is the Wireless Controller.

#### **Product Specification**

Clock frequency in the system	26MHz and 8MHz
Operating Temperature	5-35 deg. C
Power Supply	DC5V (USB Bus Power)
Battery Supply	DC3.6V
Size	200 x 46 mm
Weight	145 g

#### **Radio Specification: Bluetooth (Ver. 2.0+EDR)**

Equipment Type	Transceiver
Frequency of Operation	2402-2480MHz
Type of Modulation	FHSS (GFSK, $\pi/4$ DQPSK, 8DPSK)
Bandwidth & Channel spacing	1MHz & 1MHz
Method of frequency generation	Synthesizer
Power Supply (inner)	DC3.2V
Antenna Type	PIFA
Antenna Gain	0.12dBi max

**UL Japan, Inc.**

**Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

## **SECTION 3: Test specification, procedures & results**

### **3.1 Test Specification**

Test Specification : FCC Part 15 Subpart C: 2010, final revised on December 6, 2010 and effective January 5, 2011

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators  
Section 15.207 Conducted limits  
Section 15.247 Operation within the bands 902-928MHz,  
2400-2483.5MHz, and 5725-5850MHz

\* The EUT complies with FCC Part 15 Subpart B: 2010, final revised on December 6, 2010.

### **3.2 Procedures and results**

Item	Test Procedure	Specification	Worst Margin	Results	Remarks	
Conducted Emission	FCC: ANSI C63.4:2009 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 ----- IC: RSS-Gen 7.2.4	QP 13.9dB, 0.51231MHz, L AV 12.4dB, 0.51231MHz, L	Complied	-	
Carrier Frequency Separation	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1) ----- IC: RSS-210 A8.1 (b)	See data.	Complied	Conducted	
20dB Bandwidth	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1) ----- IC: RSS-210 A8.1 (a)		-	Conducted	
Number of Hopping Frequency	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1)(iii) ----- IC: RSS-210 A8.1 (d)		Complied	Conducted	
Dwell time	FCC: FCC Public Notice DA 00-705 IC: -	FCC: Section15.247(a)(1)(iii) ----- IC: RSS-210 A8.1 (d)		Complied	Conducted	
Maximum Peak Output Power	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.8	FCC: Section15.247(a)(b)(1) ----- IC: RSS-210 A8.4 (2)		Complied	Conducted	
Spurious Emission & Band Edge Compliance	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.9	FCC: Section15.247(d) ----- IC: RSS-210 A8.5 RSS-Gen 6 and 7.2.3		7.7dB 2400.000MHz, PK, Hori.	Complied	Conducted/ Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

\* In case any questions arise about test procedure, ANSI C63.4: 2009 is also referred.

**FCC 15.31 (e)**

This EUT provides stable voltage(DC3.2V) constantly to RF part regardless of input voltage. Therefore, this EUT complies with the requirement.

**FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

**3.3 Addition to standard**

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

**3.4 Uncertainty**

**EMI**

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Conducted emission (+dB)
	150kHz-30MHz
No.1	3.1dB
No.2	3.3dB
No.3	3.7dB
No.4	3.2dB

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	3.5dB	5.1dB	5.2dB	4.8dB	5.1dB	4.4dB	4.3dB
No.2	4.0dB	5.1dB	5.2dB	4.8dB	5.0dB	4.3dB	4.2dB
No.3	4.2dB	4.7dB	5.2dB	4.8dB	5.0dB	4.5dB	4.2dB
No.4	4.0dB	5.0dB	5.1dB	4.8dB	5.0dB	5.1dB	4.2dB

\*3m/1m/0.5m = Measurement distance

Power meter (+dB)	
Below 1GHz	Above 1GHz
1.0dB	1.0dB

Antenna terminal conducted emission and Power density (+dB)			Antenna terminal conducted emission (+dB)		Channel power (±dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz	26.5GHz-40GHz	
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test

The data listed in this test report has enough margin, more than the site margin.

**UL Japan, Inc.**

**Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

### 3.5 Test Location

UL Japan, Inc. Head Office EMC Lab. \*NVLAP Lab. code: 200572-0  
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN  
Telephone : +81 596 24 8116 Facsimile : +81 596 24 8124

	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX.

## **SECTION 4: Operation of E.U.T. during testing**

### **4.1 Operating Mode(s)**

Bluetooth (BT): Transmitting (Tx), Payload: PRBS9  
Receiving (Rx)  
Inquiry

#### Details of Operating Mode(s)

<b>Test Item</b>	<b>Mode</b>	<b>Tested frequency</b>
Conducted Emission, Spurious Emission (Conducted/Radiated)	Tx (Hopping off) DH5, 3DH5	2402MHz 2441MHz 2480MHz
	Rx	2441MHz
Carrier Frequency Separation	Tx (Hopping on) DH5, 3DH5 Inquiry	2402MHz 2441MHz 2480MHz
20dB Bandwidth	Tx (Hopping off) DH5, 3DH5 Inquiry	2402MHz 2441MHz 2480MHz
Number of Hopping Frequency	Tx (Hopping on) DH5, 3DH5 Inquiry	-
Dwell time	Tx (Hopping on), -DH1, DH3, DH5 -3DH1, 3DH3, 3DH5 Inquiry	-
Maximum Peak Output Power	Tx (Hopping off) DH5, 3DH5 Inquiry	2402MHz 2441MHz 2480MHz
Band Edge Compliance (Conducted)	Tx DH5, 3DH5 -Hopping on -Hopping off	2402MHz 2480MHz
99% Occupied Bandwidth	Tx DH5, 3DH5 -Hopping on -Hopping off	2402MHz 2441MHz 2480MHz
<p>*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload length (except Dwell time test)  *EUT has the power settings by the software as follows;  Power settings: BDR: Ext.=255, Int.=49  EDR: Ext.=255, Int.=95  Software: CSR BlueSuite BlueTest 3 Version 2.2.0.0  CSR BlueSuite BtCliCtrl Version 2.2.0.0 (Inquiry mode only)  *This setting of software is the worst case.  Any conditions under the normal use do not exceed the condition of setting.  In addition, end users cannot change the settings of the output power of the product.</p>		

**UL Japan, Inc.**

**Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

## 4.2 Configuration and peripherals

**This page has been submitted for a separate exhibit.**



## **SECTION 5: Conducted Emission**

### **Test Procedure and conditions**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

#### For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber . The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

<b>Detector</b>	<b>: QP and AV</b>
<b>Measurement range</b>	<b>: 0.15-30MHz</b>
<b>Test data</b>	<b>: APPENDIX</b>
<b>Test result</b>	<b>: Pass</b>

---

**UL Japan, Inc.**

**Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

## **SECTION 6: Radiated Spurious Emission**

### **Test Procedure**

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 0.8m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

### **Test Antennas are used as below;**

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	Below 1GHz	Above 1GHz	
Instrument used	Test Receiver	Spectrum Analyzer	
Detector	QP	PK	AV
IF Bandwidth	BW 120kHz(T/R)	RBW: 1MHz VBW: 3MHz	RBW: 1MHz VBW: 10Hz or RBW: 1MHz VBW: 270Hz *1)
Test Distance	3m	3m (below 10GHz), 1m *2) (above 10GHz),	

\*1) Used for the band edge of the carrier and the harmonics that can be measured. The VBW is based on the inverse of the duty cycle (see Appendix).

\*2) Distance Factor:  $20 \times \log(3.0\text{m}/1.0\text{m}) = 9.5\text{dB}$

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

**Measurement range** : 30M-25GHz  
**Test data** : APPENDIX  
**Test result** : Pass

**UL Japan, Inc.**

**Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8116

Facsimile : +81 596 24 8124

## **SECTION 7: Antenna Terminal Conducted Tests**

### **Test Procedure**

The tests were made with below setting connected to the antenna port.

<b>Test</b>	<b>Span</b>	<b>RBW</b>	<b>VBW</b>	<b>Sweep time</b>	<b>Detector</b>	<b>Trace</b>	<b>Instrument used</b>
20dB Bandwidth	3MHz	30kHz	100kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 3% of Span	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak	-	Power Meter (Sensor: 50MHz BW)
Carrier Frequency Separation	5MHz / 3MHz	100kHz / 30kHz	300kHz / 100kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Number of Hopping Frequency	30MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer
Dwell Time	Zero Span	1MHz	3MHz	As necessary capture the entire dwell time per hopping channel	Peak	Clear Write	Spectrum Analyzer
Conducted Spurious Emission *1)	9kHz to 150kHz	200kHz	620kHz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	10kHz	30kHz				
	30MHz-25GHz (Less or equal to 5GHz)	100kHz	300kHz				
Conducted Spurious Emission Band Edge compliance	20MHz	300kHz	1MHz	Auto	Peak	Max Hold	Spectrum Analyzer

\*1) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents. Then, wide-band noise near the limit was checked separately, however the noise was low enough as shown in the chart. (9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz) Since the margin is more than about 50 dB, the EUT complies with the limit of FCC15.209 if the measurement is performed with RBW=100kHz.

The test results and limit are rounded off to two decimals place, so some differences might be observed.

**Test data** : APPENDIX  
**Test result** : Pass